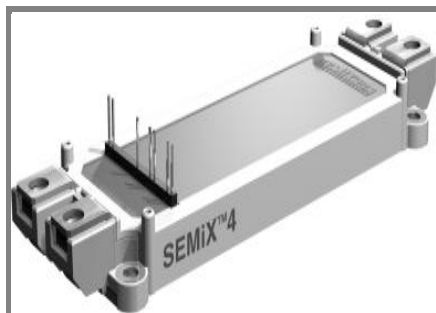


SEMIX 754GB128D



SEMIX[®] 4

SPT IGBT Modules

SEMIX 754GB128D

Preliminary Data

Features

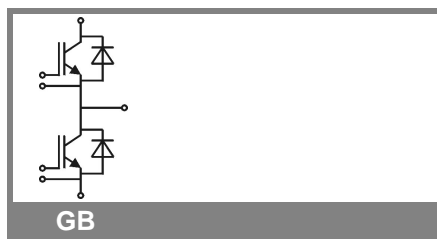
- Homogeneous Si
- SPT = Soft-Punch-Through technology
- $V_{CE(sat)}$ with positive temperature coefficient
- High short circuit capability

Typical Applications

- AC inverter drives
- UPS
- Electronic welders up to 20 kHz

Remarks

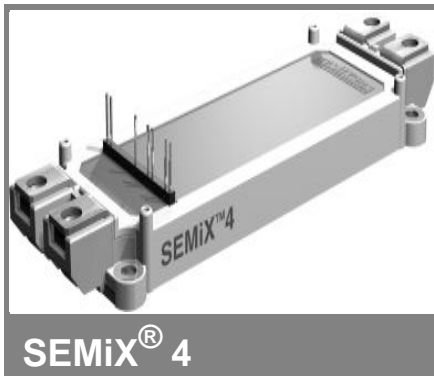
- Not for new design



Absolute Maximum Ratings		$T_{case} = 25^{\circ}C$, unless otherwise specified			
Symbol	Conditions	Values			Units
IGBT					
V_{CES}	$T_j = 25^{\circ}C$	1200			V
I_C	$T_j = 150^{\circ}C$	$T_{case} = 25^{\circ}C$	750		A
		$T_{case} = 80^{\circ}C$	530		A
I_{CRM}	$I_{CRM} = 2 \times I_{Cnom}$, $t_p = 1\text{ ms}$	800			A
V_{GES}		± 20			V
t_{psc}	$V_{CC} = 600\text{ V}$; $V_{GE} \leq 20\text{ V}$; $T_j = 125^{\circ}C$ $V_{CES} < 1200\text{ V}$	10			μs
Inverse Diode					
I_F	$T_j = 150^{\circ}C$	$T_{case} = 25^{\circ}C$	530		A
		$T_{case} = 80^{\circ}C$	360		A
I_{FRM}	$I_{FRM} = 2 \times I_{Fnom}$, $t_p = 1\text{ ms}$	800			A
I_{FSM}	$t_p = 10\text{ ms}$; sin.	$T_j = 25^{\circ}C$	3100		A
Module					
$I_{t(RMS)}$		600			A
T_{vj}		-40 ... +150			$^{\circ}C$
T_{stg}	$T_{OPERATION} \leq T_{stg}$	-40 ... +125			$^{\circ}C$
V_{isol}	AC, 1 min.	4000			V

Characteristics		$T_{case} = 25^{\circ}C$, unless otherwise specified				
Symbol	Conditions	min.	typ.	max.	Units	
IGBT						
$V_{GE(th)}$	$V_{GE} = V_{CE}$, $I_C = 16\text{ mA}$	4,5	5	6,5	V	
I_{CES}	$V_{GE} = 0\text{ V}$, $V_{CE} = V_{CES}$	$T_j = 25^{\circ}C$	0,2		0,6	mA
		$T_j = 125^{\circ}C$	0,9		1,05	V
V_{CE0}			1	1,15	V	
r_{CE}	$V_{GE} = 15\text{ V}$	$T_j = 25^{\circ}C$	2,3		2,9	m Ω
		$T_j = 125^{\circ}C$	3		3,8	m Ω
$V_{CE(sat)}$	$I_{Cnom} = 400\text{ A}$, $V_{GE} = 15\text{ V}$	$T_j = 25^{\circ}C_{chiplev.}$	1,7	1,9	2,35	V
		$T_j = 125^{\circ}C_{chiplev.}$		2,3	2,55	V
C_{ies}	$V_{CE} = 25$, $V_{GE} = 0\text{ V}$	$f = 1\text{ MHz}$	36		nF	
C_{oes}			2,7		nF	
C_{res}			1,7		nF	
Q_G	$V_{GE} = -8\text{ V} \dots +15\text{ V}$	3800			nC	
$t_{d(on)}$	$R_{Gon} = 2,5\ \Omega$	$V_{CC} = 600\text{ V}$ $I_{Cnom} = 400\text{ A}$	180		ns	
t_r			88		ns	
E_{on}	$R_{Goff} = 2,5\ \Omega$	$T_j = 125^{\circ}C$	44		mJ	
$t_{d(off)}$			655		ns	
t_f			118		ns	
E_{off}			48		mJ	
$R_{th(j-c)}$	per IGBT	0,042			K/W	

SEMiX 754GB128D



SPT IGBT Modules

SEMiX 754GB128D

Preliminary Data

Features

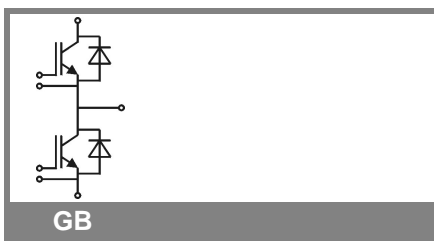
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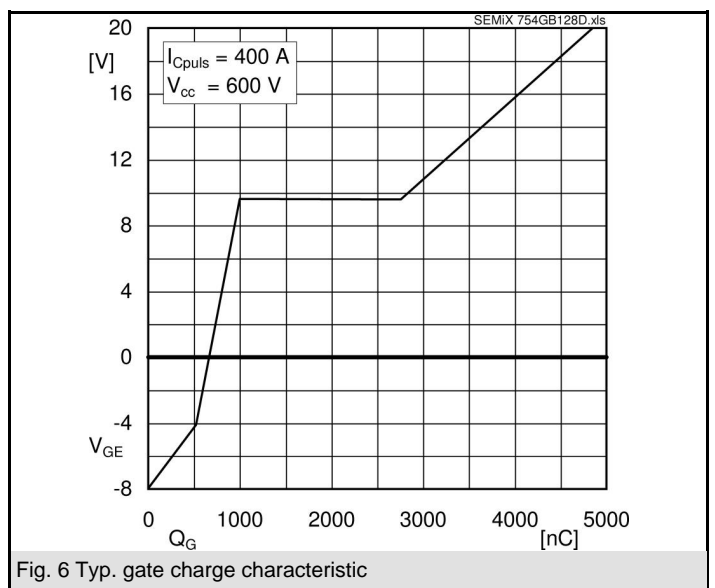
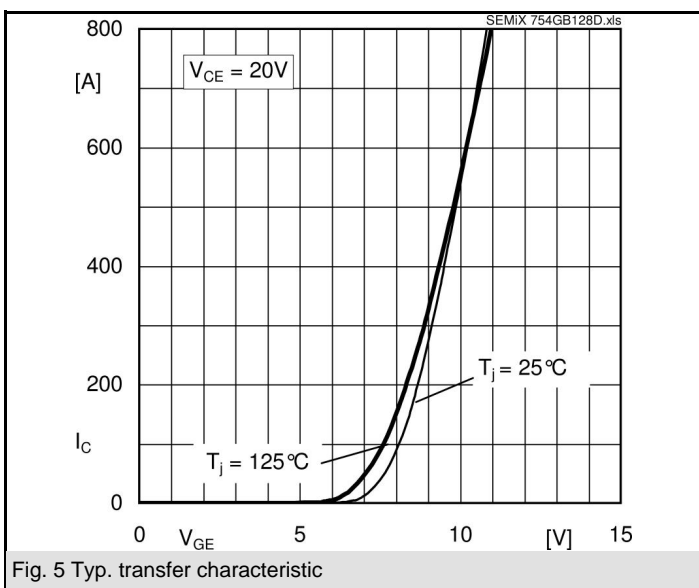
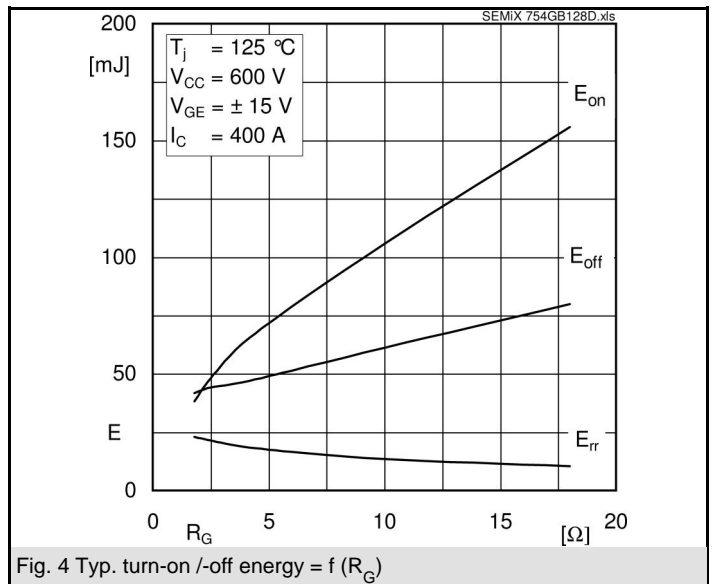
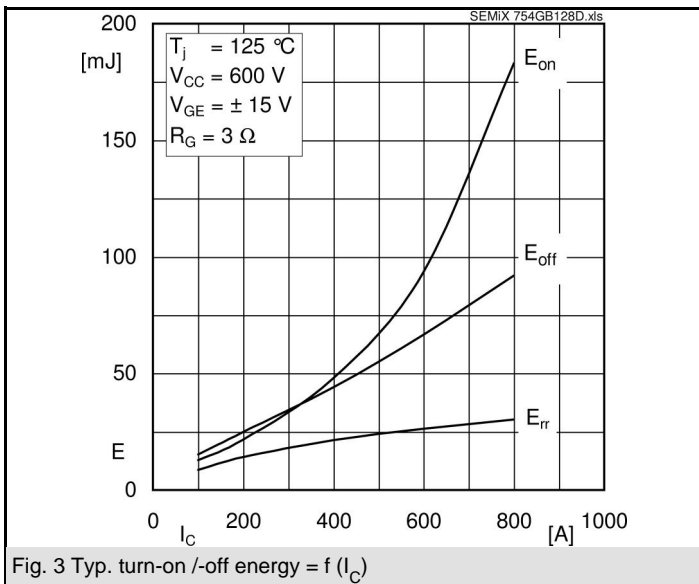
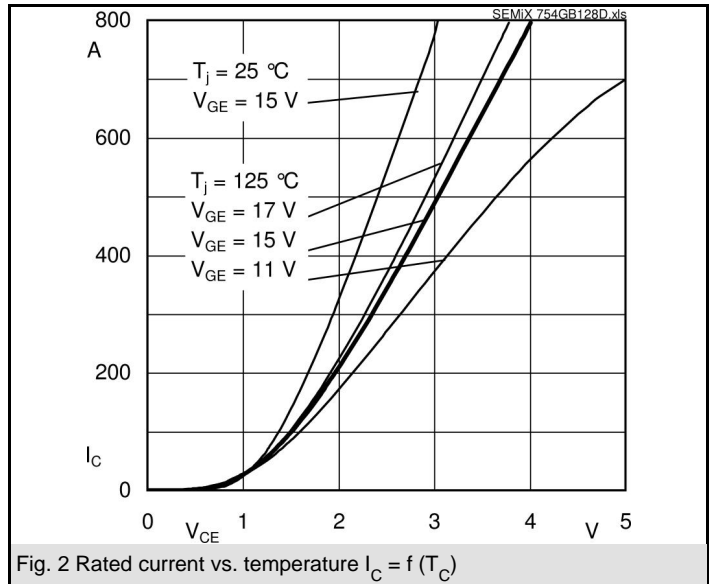
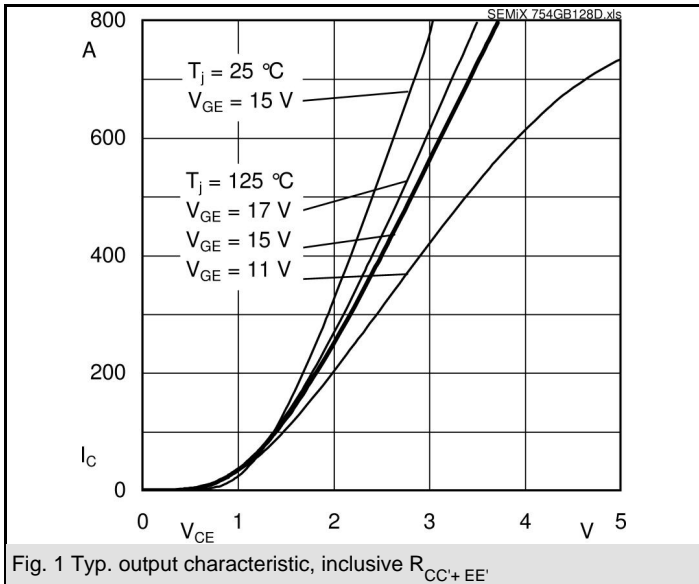


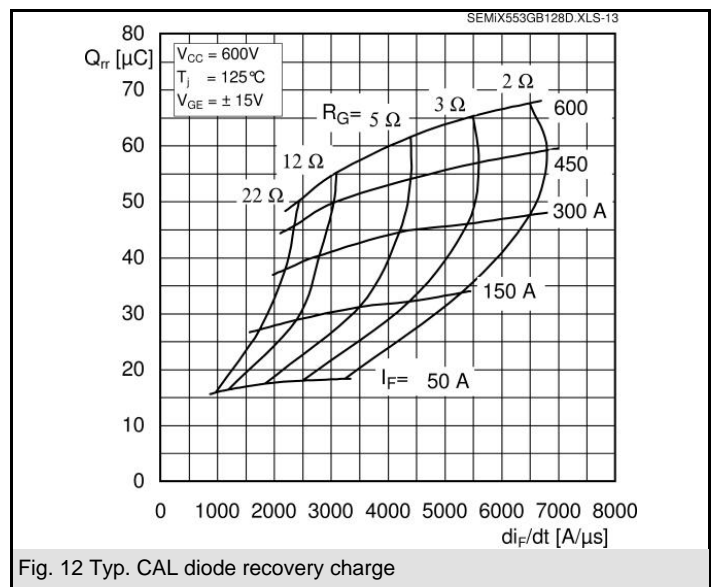
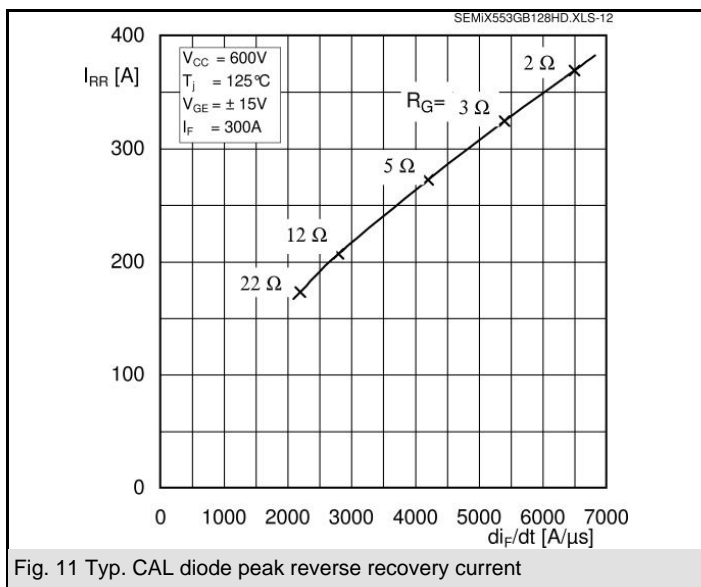
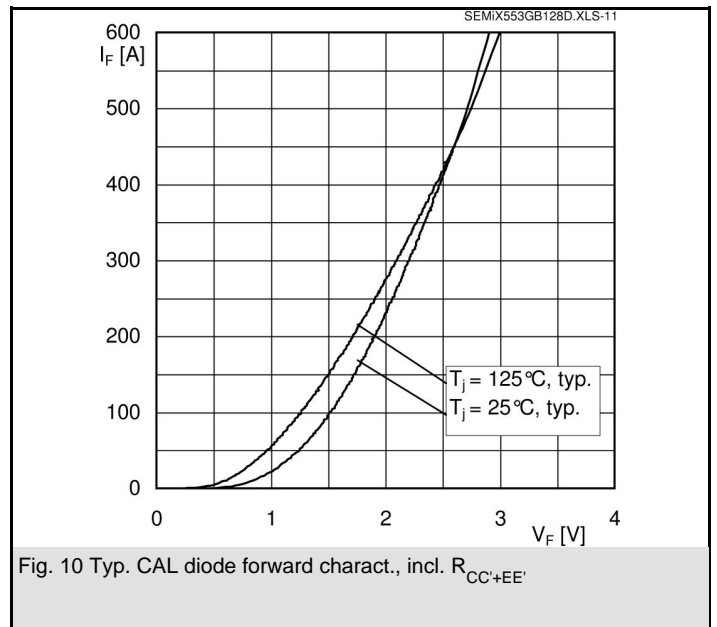
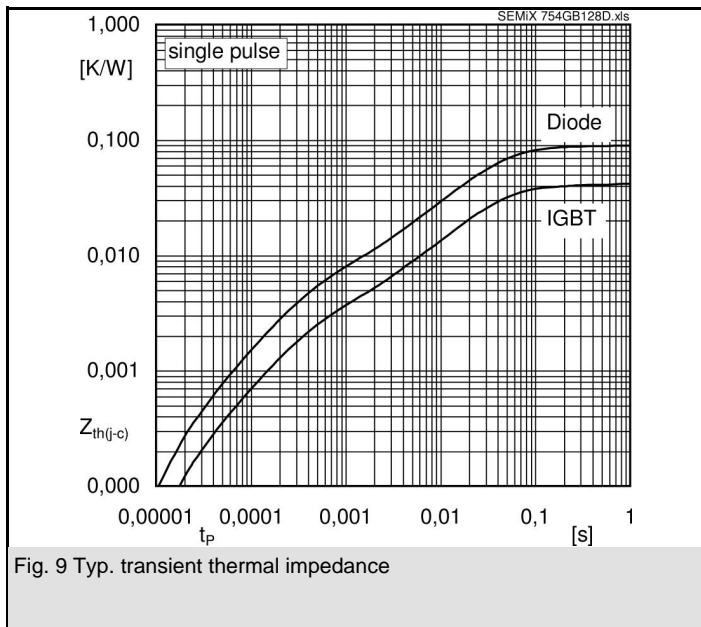
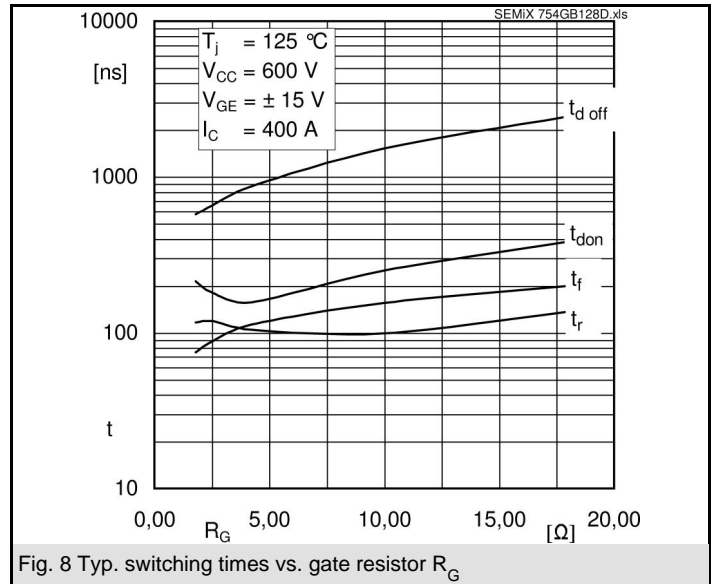
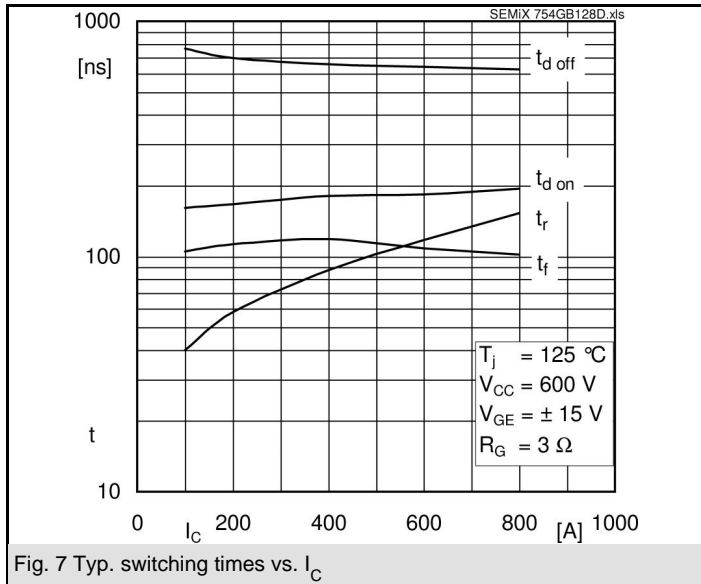
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Characteristics					
Symbol	Conditions	min.	typ.	max.	Units
Inverse Diode					
$V_F = V_{EC}$	$I_{Fnom} = 400 \text{ A}; V_{GE} = 0 \text{ V}$		2	2,5	V
			1,8	2,3	V
V_{F0}			1,1	1,5	V
				1,3	V
r_F			2,3	2,5	mΩ
				2,5	mΩ
I_{RRM}	$I_{Fnom} = 400 \text{ A}$		367		A
Q_{rr}	$di/dt = 5880 \text{ A}/\mu\text{s}$		58		μC
E_{off}	$V_{GE} = -15 \text{ V}; V_{CC} = 600 \text{ V}$		58		mJ
$R_{th(j-c)D}$	per diode			0,09	K/W
Module					
L_{CE}			22		nH
$R_{CC'+EE'}$	res., terminal-chip	$T_{case} = 25 \text{ °C}$	0,7		mΩ
		$T_{case} = 125 \text{ °C}$	1		mΩ
$R_{th(c-s)}$	per module		0,03		K/W
M_s	to heat sink (M5)		3	5	Nm
M_t	to terminals (M6)		2,5	5	Nm
w				400	g
Temperature sensor					
R_{100}	$T_c = 100 \text{ °C}$ ($R_{25} = 5 \text{ k}\Omega$)		0,493±5%		kΩ
$B_{100/125}$	$R(T) = R_{100} \exp[B_{100/125} (1/T - 1/T_{100})]$; $T[\text{K}]; B$		3550±2%		K

This is an electrostatic discharge sensitive device (ESDS), international standard IEC 60747-1, Chapter IX.

This technical information specifies semiconductor devices but promises no characteristics. No warranty or guarantee expressed or implied is made regarding delivery, performance or suitability.

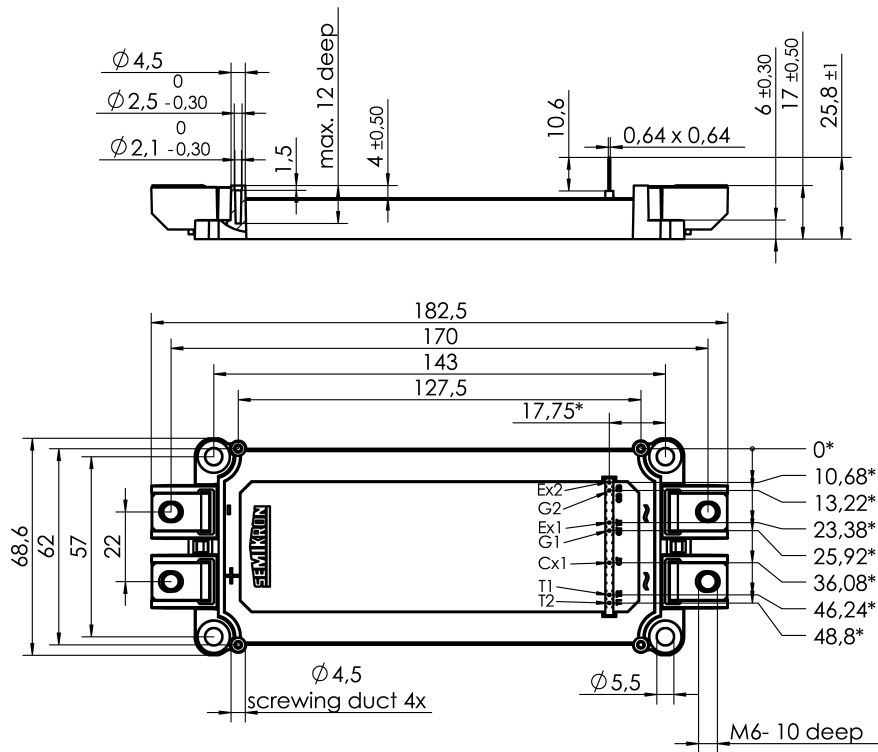




SEMiX 754GB128D

UL Recognized
File no. E 63 532

Dimensions in mm



*= all measures with $\pm 0,5$

Case SEMiX 4

